

**Search Notes**

Application/Control No.

10/710,871

Examiner

M. Lee

Applicant(s)/Patent under  
Reexamination

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Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	441, 452, 451, 448, 459, 699,	5/18/2007	ML
	700, 581,		
	554, 555		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference search history printout		5/18/2007	ML

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/18/2007	ML